

Notice of References Cited	Application/Control No. 10/620,402	Applicant(s)/Patent Under Reexamination SEMPER ET AL.	
	Examiner MICHAEL T. VU	Art Unit 2617	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0114305	08-2002	Oyama et al.	370/338
*	B	US-2003/0137944	07-2003	Medvinsky, Alexander	370/252
	C	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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